Part Numbering

Chip Monolithic Ceramic Capacitors

GR M 18 8 B1 1H 102 K A01 D (Part Number) 0 2 3 4 5 6 7 8 9 0

Product ID

2Series

-	1	I	
Product ID	Code	Series	
	J	Soft Termination Type	
GR	М	Tin Plated Layer	
GK	4	Only for Information Devices / Tip & Ring	
	7	Only for Camera Flash Circuit	
GQ	M High Frequency for Flow/Reflow Soldering		
GM	Α	Monolithic Microchip	
GIVI	D	For Bonding	
GN	M Capacitor Array		
	L	Low ESL Type	
LL	R	Controlled ESR Low ESL Type	
LL	Α	8-termination Low ESL Type	
	М	10-termination Low ESL Type	
GJ M High Freq		High Frequency Low Loss Type	
•	2	For AC250V (r.m.s.)	
GA	3	Safety Standard Certified Type	

3Dimensions (LXW)

Code	Dimensions (LXW)	EIA
02	0.4×0.2mm	01005
03	0.6×0.3mm	0201
05	0.5×0.5mm	0202
08	0.8×0.8mm	0303
0D	0.38×0.38mm	015015
OM	0.9×0.6mm	0302
15	1.0×0.5mm	0402
18	1.6×0.8mm	0603
1M	1.37×1.0mm	0504
21	2.0×1.25mm	0805
22	2.8×2.8mm	1111
31	3.2×1.6mm	1206
32	3.2×2.5mm	1210
42	4.5×2.0mm	1808
43	4.5×3.2mm	1812
52	5.7×2.8mm	2211
55	5.7×5.0mm	2220

4Dimension (T) (Except GNM)

Code	Dimension (T)		
	, ,		
2	0.2mm		
3	0.3mm		
5	0.5mm		
6	0.6mm		
7	0.7mm		
8	0.8mm		
9	0.85mm		
Α	1.0mm		
В	1.25mm		
С	1.6mm		
D	2.0mm		
E	2.5mm		
F	3.2mm		
M	1.15mm		
N	1.35mm		
Q	1.5mm		
R	1.8mm		
s	2.8mm		
Х	Depends on individual standards.		

4Elements (**GNM** Only)

Code	Elements
2	2-elements
4	4-elements





5Temperature Characteristics

Temperature Characteristic Codes						
Code	Public STD (Public STD Code Reference Temperature Range Capacitance Change or Temperature Coefficient		Operating Temperature Range		
1X	SL *1	JIS	20°C	20 to 85°C	+350 to -1000ppm/°C	-55 to 125°C
2C	CH *1	JIS	20°C	20 to 125°C	0±60ppm/°C	-55 to 125°C
2P	PH *1	JIS	20°C	20 to 85°C	-150±60ppm/°C	-25 to 85°C
2R	RH *1	JIS	20°C	20 to 85°C	-220±60ppm/°C	-25 to 85°C
28	SH *1	JIS	20°C	20 to 85°C	-330±60ppm/°C	-25 to 85°C
2T	TH *1	JIS	20°C	20 to 85°C	-470±60ppm/°C	-25 to 85°C
3C	CJ *1	JIS	20°C	20 to 125°C	0±120ppm/°C	-55 to 125°C
3P	PJ *1	JIS	20°C	20 to 85°C	-150±120ppm/°C	-25 to 85°C
3R	RJ *1	JIS	20°C	20 to 85°C	-220±120ppm/°C	-25 to 85°C
3S	SJ *1	JIS	20°C	20 to 85°C	-330±120ppm/°C	-25 to 85°C
3T	TJ *1	JIS	20°C	20 to 85°C	-470±120ppm/°C	-25 to 85°C
3U	UJ *1	JIS	20°C	20 to 85°C	-750±120ppm/°C	-25 to 85°C
4C	CK *1	JIS	20°C	20 to 125°C	0±250ppm/°C	-55 to 125°C
5C	C0G *1	EIA	25°C	25 to 125°C	0±30ppm/°C	-55 to 125°C
5G	X8G *1	EIA	25°C	25 to 150°C	0±30ppm/°C	-55 to 150°C
6C	C0H *1	EIA	25°C	25 to 125°C	0±60ppm/°C	-55 to 125°C
6P	P2H *1	EIA	25°C	25 to 85°C	-150±60ppm/°C	-55 to 125°C
6R	R2H *1	EIA	25°C	25 to 85°C	-220±60ppm/°C	-55 to 125°C
6S	S2H *1	EIA	25°C	25 to 85°C	-330±60ppm/°C	-55 to 125°C
6T	T2H *1	EIA	25°C	25 to 85°C	-470±60ppm/°C	-55 to 125°C
7U	U2J *1	EIA	25°C	25 to 125°C *6	-750±120ppm/°C	-55 to 125°C
B1	B *2	JIS	20°C	-25 to 85°C	±10%	-25 to 85°C
В3	В	JIS	20°C	-25 to 85°C	±10%	-25 to 85°C
C7	X7S	EIA	25°C	-55 to 125°C	±22%	-55 to 125°C
C8	X6S	EIA	25°C	-55 to 105°C	±22%	-55 to 105°C
D7	X7T	EIA	25°C	-55 to 125°C	+22, -33%	-55 to 125°C
D8	X6T	EIA	25°C	-55 to 105°C	+22, -33%	-55 to 105°C
E7	X7U	EIA	25°C	-55 to 125°C	+22, -56%	-55 to 125°C
F1	F *2	JIS	20°C	-25 to 85°C	+30, -80%	-25 to 85°C
F5	Y5V	EIA	25°C	-30 to 85°C	+22, -82%	-30 to 85°C
L8	X8L	*3	25°C	-55 to 150°C	+15, -40%	-55 to 150°C
R1	R *2	JIS	20°C	-55 to 125°C	±15%	-55 to 125°C
R3	R	JIS	20°C	-55 to 125°C	±15%	-55 to 125°C
R6	X5R	EIA	25°C	-55 to 85°C	±15%	-55 to 85°C
R7	X7R	EIA	25°C	-55 to 125°C	±15%	-55 to 125°C
R9	X8R	EIA	25°C	-55 to 150°C	±15%	-55 to 150°C
WO			25.0	FE 1- 40500	±10% *4	FF / 40500
W0	25°C -55 to 125°C +22, -33% *5		25°C	-55 to 125°C	+22, -33% *5	-55 to 125°C

^{*1} Please refer to table for Capacitance Change under reference temperature.





^{*2} Capacitance change is specified with 50% rated voltage applied.

^{*3} Murata Temperature Characteristic Code.

^{*4} Apply DC350V bias.

^{*5} No DC bias.

^{*6} Rated Voltage 100Vdc max : 25 to 85°C

●Capacitance Change from each temperature

JIS Code

	Capacitance Change from 20°C (%)						
Murata Code	-55	5°C	-25	−25°C)°C	
	Max.	Min.	Max.	Min.	Max.	Min.	
1X	-	-	-	-	-	_	
2C	0.82	-0.45	0.49	-0.27	0.33	-0.18	
2P	-	-	1.32	0.41	0.88	0.27	
2R	-	_	1.70	0.72	1.13	0.48	
28	-	_	2.30	1.22	1.54	0.81	
2T	-	_	3.07	1.85	2.05	1.23	
3C	1.37	-0.90	0.82	-0.54	0.55	-0.36	
3P	-	_	1.65	0.14	1.10	0.09	
3R	-	-	2.03	0.45	1.35	0.30	
38	-	_	2.63	0.95	1.76	0.63	
3T	-	-	3.40	1.58	2.27	1.05	
3U	-	-	4.94	2.84	3.29	1.89	
4C	2.56	-1.88	1.54	-1.13	1.02	-0.75	

EIA Code

	Capacitance Change from 25°C (%)					
Murata Code	−55°C		−30°C		-10°C	
	Max.	Min.	Max.	Min.	Max.	Min.
5C/5G	0.58	-0.24	0.40	-0.17	0.25	-0.11
6C	0.87	-0.48	0.59	-0.33	0.38	-0.21
6P	2.33	0.72	1.61	0.50	1.02	0.32
6R	3.02	1.28	2.08	0.88	1.32	0.56
6S	4.09	2.16	2.81	1.49	1.79	0.95
6T	5.46	3.28	3.75	2.26	2.39	1.44
7U	8.78	5.04	6.04	3.47	3.84	2.21

6 Rated Voltage

Code	Rated Voltage			
0E	DC2.5V			
0G	DC4V			
0J	DC6.3V			
1A	DC10V			
1C	DC16V			
1E	DC25V			
YA	DC35V			
1H	DC50V			
2A	DC100V			
2D	DC200V			
2E	DC250V			
YD	DC300V			
2H	DC500V			
2J	DC630V			
3A	DC1kV			
3D	DC2kV			
3F	DC3.15kV			
ВВ	DC350V (for Camera Flash Circuit)			
E2	AC250V			
GC	X1/Y2; AC250V (Safety Standard Certified Type GC)			
GF	Y2, X1/Y2; AC250V (Safety Standard Certified Type GF)			
GD	Y3; AC250V (Safety Standard Certified Type GD)			
GB	X2; AC250V (Safety Standard Certified Type GB)			

Capacitance

Expressed by three-digit alphanumerics. The unit is picofarad (pF). The first and second figures are significant digits, and the third figure expresses the number of zeros which follow the two numbers.If there is a decimal point, it is expressed by the capital letter "R." In this case, all figures are significant digits.

Ex.)	Code	Capacitance
	R50	0.5pF
	1R0	1.0pF
	100	10pF
	103	10000pF





8 Capacitance Tolerance

Code	Capacitance Tolerance	TC	Series	Ca	pacitance Step
W	±0.05pF	СΔ	GRM/GJM	≦9.9pF	0.1pF
			GRM/GJM	≦9.9pF	0.1pF
В	±0.1pF	СΔ	GQM	≦1pF	0.1pF
			GQIVI	1.1 to 9.9pF	1pF Step and E24 Series
		СΔ	GRM/GJM	≦9.9pF	0.1pF
С	±0.25pF	except C∆	GRM	≦5pF	* 1pF
C	_0.23β1	СД	GQM	≦1pF	0.1pF
		CA	GQIVI	1.1 to 9.9pF	1pF Step and E24 Series
		СΔ	GRM/GJM	5.1 to 9.9pF	0.1pF
D	±0.5pF	except C∆	GRM	5.1 to 9.9pF	* 1pF
		СΔ	GQM	5.1 to 9.9pF	1pF Step and E24 Series
G	±2%	СΔ	GJM	≥10pF	E12 Series
G	±2 70	СΔ	GQM	≥10pF	E24 Series
	J ±5%	CΔ, SL, U2J	GRM/GA3	≧10pF	E12 Series
		СΔ	GQM/GJM	≧10pF	E24 Series
		B, R, X7R, X5R, ZLM	GRJ/GRM/GR7/GA3		E6 Series
K	±10%	COG	GNM		E6 Series
		B, R, X7R, X5R, ZLM	GR4, GMD		E12 Series
		B, R, X7R, X7S	GRM/GMA		E6 Series
М	±20%	X5R, X7R, X7S	GNM		E3 Series
IVI	±2076	X7R	GA2		E3 Series
		X5R, X7R, X7S, X6S	LLL/LLR/LLA/LLM		E3 Series
Z	+80%, -20%	F, Y5V	GRM		E3 Series
R		Depend	ls on individual standards.	·	

^{*} E24 series is also available.

Individual Specification Code (Except LLR)

Expressed by three figures.

9ESR (**LLR** Only)

Code	ESR
E01	100mΩ
E03	220mΩ
E05	470mΩ
E07	1000mΩ

Packaging

Code	Packaging		
L	ø180mm Embossed Taping		
D	ø180mm Paper Taping		
E	ø180mm Paper Taping (LLL15)		
K	ø330mm Embossed Taping		
J	ø330mm Paper Taping		
F	ø330mm Paper Taping (LLL15)		
В	Bulk		
С	Bulk Case		
Т	Bulk Tray		

Please check the MURATA home page (http://www.murata.com/) if you cannot find the part number in the catalog.



Chip Monolithic Ceramic Capacitors



AC250V Type (Which Meet Japanese Law) GA2 Series

■ Features

- 1. Chip monolithic ceramic capacitor for AC lines.
- 2. A new monolithic structure for small, high capacitance capable of operating at high voltage levels.
- 3. Sn-plated external electrodes realize good solderability.
- 4. Only for reflow soldering
- 5. Capacitance 0.01 to 0.1uF for connecting lines and 470 to 4700pF for connecting lines to earth.

Applications

Noise suppression filters for switching power supplies, telephones, facsimiles, modems.

Do not use these products in any Automotive Power train or Safety equipment including Battery chargers for Electric Vehicles and Plug-in Hybrids. Only Murata products clearly stipulated as "for Automotive use" can be used for automobile applications such as Power train and Safety equipment.

■ Reference Standard

GA2 series obtains no safety approval. This series is based on the standards of the electrical appliance and material safety law of Japan (separated table 4).

4	2	-		
4			4	0
		9		



Part Number	Dimensions (mm)							
Part Number	L	W	T	e min.	g min.			
GA242Q	4.5 ±0.3	2.0 ±0.2	1.5 +0, -0.3					
GA243D	4.5 ±0.4	3.2 +0.3	2.0 +0, -0.3	0.3	2.5			
GA243Q	4.5 ±0.4	3.2 ±0.3	1.5 +0, -0.3	0.3				
GA255D	5.7 ±0.4	5.0 ±0.4	2.0 +0, -0.3		3.2			

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GA242QR7E2471MW01L	AC250 (r.m.s.)	X7R (EIA)	470pF ±20%	4.5	2.0	1.5	2.5	0.3 min.
GA242QR7E2102MW01L	AC250 (r.m.s.)	X7R (EIA)	1000pF ±20%	4.5	2.0	1.5	2.5	0.3 min.
GA243QR7E2222MW01L	AC250 (r.m.s.)	X7R (EIA)	2200pF ±20%	4.5	3.2	1.5	2.5	0.3 min.
GA243QR7E2332MW01L	AC250 (r.m.s.)	X7R (EIA)	3300pF ±20%	4.5	3.2	1.5	2.5	0.3 min.
GA243DR7E2472MW01L	AC250 (r.m.s.)	X7R (EIA)	4700pF ±20%	4.5	3.2	2.0	2.5	0.3 min.
GA243QR7E2103MW01L	AC250 (r.m.s.)	X7R (EIA)	10000pF ±20%	4.5	3.2	1.5	2.5	0.3 min.
GA243QR7E2223MW01L	AC250 (r.m.s.)	X7R (EIA)	22000pF ±20%	4.5	3.2	1.5	2.5	0.3 min.
GA243DR7E2473MW01L	AC250 (r.m.s.)	X7R (EIA)	47000pF ±20%	4.5	3.2	2.0	2.5	0.3 min.
GA255DR7E2104MW01L	AC250 (r.m.s.)	X7R (EIA)	0.10μF ±20%	5.7	5.0	2.0	3.2	0.3 min.

GA2 Series Specifications and Test Methods

No.	Ite	m	Specifications	Test Method			
1	Operating Temperatu	ıre Range	−55 to +125°C	_			
2	Appearan	ice	No defects or abnormalities	Visual inspection			
3	Dimensio	ns	Within the specified dimensions	Using calipers and micrometers			
4	Dielectric Strength		No defects or abnormalities	No failure should be observed when voltage in the table is applied between the terminations for 60±1 sec., provided the charge/discharge current is less than 50mA. Nominal Capacitance Test Voltage C≥10,000pF AC575V (r.m.s.) C<10,000pF AC1500V (r.m.s.)			
5	Insulation F	Pesistance More than 2,000MΩ		The insulation resistance should be measured with DC500±50V			
	(I.R.)			and within 60±5 sec. of charging.			
6	Capacitar	nce	Within the specified tolerance	The capacitance/D.F. should be measured at a frequency of			
7	Dissipation Factor (D.		0.025 max.	1±0.2kHz and a voltage of AC1±0.2V (r.m.s.)			
8	Temperature		Cap. Change Within ±15% (Temp. Range: −55 to +125℃)	The capacitance measurement should be made at each step specified in the Table. Step Temperature (°C) 1 25±2 2 Min. Operating Temp.±3 3 25±2 4 Max. Operating Temp.±2 5 25±2 • Pretreatment Perform a heat treatment at 150 ⁺ / ₋₁ %° for 60±5 min. and then let sit for 24±2 hrs. at room condition.*			
9	Discharge Test (Application: Nominal Capacitance C<10,000pF)	Appearance	No defects or abnormalities	As in Fig., discharge is made 50 times at 5 sec. intervals from the capacitor (Cd) charged at DC voltage of specified. R1 T 10kV Cd Cd Cd Ct R2 Ct: Capacitor under test Cd: 0.001μF R1: 1,000Ω R2: 100ΜΩ R3: Surge resistance			
10	Adhesive Strength of Termination		No removal of the terminations or other defects should occur.	Solder the capacitor to the testing jig (glass epoxy board) shown in Fig. 1. Then apply 10N force in the direction of the arrow. The soldering should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.			
		Appearance	No defects or abnormalities	Solder the capacitor to the test jig (glass epoxy board).			
		Capacitance	Within the specified tolerance	The capacitor should be subjected to a simple harmonic motion			
11	Vibration Resistance	on		having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 min. This motion should be applied for a period of 2 hrs. in each of 3 mutually perpendicular directions (total of 6 hrs.). Solder resist			

 $^{^{\}star}$ "Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa





GA2 Series Specifications and Test Methods

 $\begin{tabular}{|c|c|c|c|}\hline \end{tabular}$ Continued from the preceding page.

No.	Ite	em		S	pecification	ıs				Test Metho	d	
12	P. Deflection		L×W (mm) 4.5×2.0 4.5×3.2 5.7×5.0	a 3.5 3.5 4.5	b 100 Fig. 2 Dimens b 7.0 7.0 8.0	04.5 t:1.6 c 2.4 3.7 5.6	d 1.0	in Fig. 2. Then apply a force in the direction shown in Fig. 3. The should be done using the reflow method and should be conducted with care so that the soldering is uniform and defects such as heat shock. 20 50 Pressurizing speed: 1.0mm/s Pressurize R230 Flexure=1 Capacitance meter 45 (in mm) Fig. 3		nould be iform and free of		
13	Solderab Terminati		75% of the termin	nations are	are to be soldered evenly and continuously.				Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight proportion). Immerse in solder solution for 2±0.5 sec. Immersing speed: 25±2.5mm/s Temp. of solder: 245±5°C Lead Free Solder (Sn-3.0Ag-0.5Cu) 235±5°C H60A or H63A Eutectic Solder			
		Appearance Capacitance Change	No marking defe	ects								
14	Humidity Insulation D.F.		0.05 max.	0.05 max.					The capacitor should be subjected to $40\pm2^{\circ}$ C, relative humidity of 90 to 98% for 8 hrs., and then removed in room condition* for 16			
			More than 1,000	ΜΩ				hrs. ι	until 5 cyc	cles.		
		Dielectric Strength	In accordance w	n accordance with item No.4								
		Appearance	No marking defe	ects					Preheat the capacitor as in table.			
		Capacitance Change	Within ±10%					Immerse the capacitor in solder solution at 260±5°C for 10±1 sec. Let sit at room condition* for 24±2 hrs., then measure. •Immersing speed: 25±2.5mm/s				
	Resistance	D.F.	0.025 max.					•Pretreatment Perform a heat treatment at 150 ⁺ ₋₁ ° for 60±5 min. and then				
15	to Soldering Heat	I.R.	More than 2,000	Ο ΜΩ				Perform a heat treatment at 150 [±] -13°C for 60±5 min. and the let sit for 24±2 hrs. at room condition.* *Preheating			±5 mm. and them	
		Dielectric Strength	In accordance w	rith item N	0.4				Step 1 2	Temperature 100 to 120℃ 170 to 200℃		Time 1 min. 1 min.
		Appearance	No marking defe	ects						tor to the supporting jig (glass ep	oxy board) shown
		Capacitance Change	Within ±15%						_	cycles according to the 4	4 heat tre	eatments listed in
		D.F.	0.05 max.					Let s	it for 24±	2 hrs. at room condition,	* then m	
		I.R.	More than 2,000	ΩΜΩ				_	Step	Temperature (℃)	+2	Time (min.)
4.	Temperature								1 2 3 4	Min. Operating Temp. Room Temp. Max. Operating Temp Room Temp.		30±3 2 to 3 30±3 2 to 3
16	16 Temperature Cycle Diele Street		In accordance with item No.4				Pretreatment Perform a heat treatment at 150 ⁺ ·10°C for 60±5 min. and then let sit for 24±2 hrs. at room condition.* Solder resist Glass Epoxy Board					

 $^{^*}$ "Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

Continued on the following page.

Fig. 4





GA2 Series Specifications and Test Methods

Continued from the preceding page.

No.	Ite	em	Specifications	Test Method
		Appearance	No marking defects	
	Humidity	Capacitance Change Within ±15%	Within ±15%	Let the capacitor sit at 40±2°C and relative humidity of 90 to 95% for 500±2°dhrs. Remove and let sit for 24±2 hrs. at room condition,* then
17	(Steady	D.F.	0.05 max.	measure.
	State)	I.R.	More than 1,000M Ω	Pretreatment Perform a heat treatment at 150 ⁺ 10 [∞] C for 60±5 min, and then
		Dielectric Strength	In accordance with item No.4	let sit for 24±2 hrs. at room condition.*
		Appearance No marking defects		Apply voltage and time as in Table at maximum operating
		Capacitance Change	Within ±20%	temperature ±3°C. Remove and let sit for 24±2 hrs. at room condition,* then measure. The charge / discharge current is less than 50mA.
		D.F. 0.05 max. I.R. More than 1,000ΜΩ	Nominal Capacitance Test Time Test Voltage	
			C≧10,000pF 1,000 ⁺⁴⁸ _o hrs. AC300V (r.m.s.)	
18	Life	Dielectric Strength	In accordance with item No.4	* Except that once each hour the voltage is increased to AC1,000V (r.m.s.) for 0.1 sec. Pretreatment Apply test voltage for 60±5 min. at test temperature. Remove and let sit for 24±2 hrs. at room condition.*
		Appearance	No marking defects	
		Capacitance Change	Within ±15%	Apply the rated voltage at 40±2°C and relative humidity of 90 to 95% for 500 ^{±24} hrs. Remove and let sit for 24±2 hrs. at room condition,* then
19	Humidity Loading	D.F.	0.05 max.	measure.
	Louding	I.R.	More than 1,000M Ω	Pretreatment Apply test voltage for 60±5 min. at test temperature.
		Dielectric Strength	In accordance with item No.4	Remove and let sit for 24±2 hrs. at room condition.*

^{* &}quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa



Chip Monolithic Ceramic Capacitors



Safety Standard Certified GA3 Series UL, IEC60384-14 Class X1/Y2 Type GC

■ Features

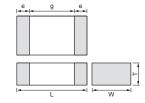
- 1. Chip monolithic ceramic capacitor (certified as conforming to safety standards) for AC lines.
- 2. A new monolithic structure for small, high capacitance capable of operating at high voltage levels.
- 3. Compared to lead type capacitors, this new capacitor is greatly downsized and low-profiled to 1/10 or less in volume, and 1/4 or less in height.
- 4. Type GC can be used as an X1-class and Y2-class capacitor, line-by-pass capacitor of UL1414.
- 5. +125 degree C guaranteed
- 6. Only for reflow soldering

Applications

- 1. Ideal for use as Y capacitor or X capacitor for various switching power supplies
- 2. Ideal for modem applications

Do not use these products in any Automotive Power train or Safety equipment including Battery chargers for Electric Vehicles and Plug-in Hybrids. Only Murata products clearly stipulated as "for Automotive use" can be used for automobile applications such as Power train and Safety equipment.





Part Number		Dimensions (mm)						
Part Number	L	W	T	e min.	g min.			
GA355D	5.7 ±0.4	5.0 ±0.4	2.0 ±0.3	0.3	4.0			

■ Standard Certification

	Standard No.	Class	Rated Voltage
UL	UL1414	Line By-pass	
VDE	IEC 60384-14 EN 60384-14		
BSI	EN 60065 (14.2) IEC 60384-14 EN 60384-14	X1, Y2	AC250V (r.m.s.)
SEMKO	IEC 60384-14 EN 60384-14		
ESTI	EN 60065 IEC 60384-14		

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GA355DR7GC101KY02L	AC250 (r.m.s.)	X7R (EIA)	100 ±10%	5.7	5.0	2.0	4.0	0.3 min.
GA355DR7GC151KY02L	AC250 (r.m.s.)	X7R (EIA)	150 ±10%	5.7	5.0	2.0	4.0	0.3 min.
GA355DR7GC221KY02L	AC250 (r.m.s.)	X7R (EIA)	220 ±10%	5.7	5.0	2.0	4.0	0.3 min.
GA355DR7GC331KY02L	AC250 (r.m.s.)	X7R (EIA)	330 ±10%	5.7	5.0	2.0	4.0	0.3 min.



Chip Monolithic Ceramic Capacitors



Safety Standard Certified GA3 Series IEC60384-14 Class Y2, X1/Y2 Type GF

■ Features

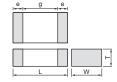
- 1. Available for equipment based on IEC/EN60950 and UL1950. Besides, the GA352/355 types are available for equipment based on IEC/EN60065, UL1492, and UL6500.
- 2. Type GF can be used as a Y2-class capacitor.
- 3. A new monolithic structure for small, high capacitance capable of operating at high voltage levels.
- 4. +125 degree C guaranteed
- 5. Only for reflow soldering

■ Applications

- 1. Ideal for use on line filters and couplings for DAA modems without transformers
- 2. Ideal for use on line filters for information equipment
- 3. Ideal for use as Y capacitor or X capacitor for various switching power supplies (GA352/355 types only)

Do not use these products in any Automotive Power train or Safety equipment including Battery chargers for Electric Vehicles and Plug-in Hybrids. Only Murata products clearly stipulated as "for Automotive use" can be used for automobile applications such as Power train and Safety equipment.





Part Number	Dimensions (mm)							
Part Number	L W T		e min.	g min.				
GA342A			1.0 +0, -0.3					
GA342D	4.5 ±0.3	2.0 ±0.2	2.0 ±0.2		2.5			
GA342Q			1.5 +0, -0.3	0.3				
GA352Q		2.8 ±0.3	1.5 +0, -0.3	0.3				
GA355D	5.7 ±0.4	5.0 +0.4	2.0 +0, -0.3		4.0			
GA355Q		3.0 ±0.4	1.5 +0, -0.3					

■ Standard Certification

	Standard		Status of C	ertification	Rated
	No.	Class	Size : 4.5×2.0mm	Size: 5.7×2.8mm and over	Voltage
UL	UL1414	X1, Y2	_	0	
UL	UL 60950-1	_	0	_	AC250V
VDE	IEC 60384-14	X1, Y2	_	0	(r.m.s.)
SEMKO	EN 60384-14	Y2	0	0	

Applications

Size	Switching power supplies	Communication network devices such as a modem		
4.5×2.0mm	_	0		
5.7×2.8mm and over	0	0		

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GA342D1XGF100JY02L	AC250 (r.m.s.)	SL (JIS)	10 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGF120JY02L	AC250 (r.m.s.)	SL (JIS)	12 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGF150JY02L	AC250 (r.m.s.)	SL (JIS)	15 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGF180JY02L	AC250 (r.m.s.)	SL (JIS)	18 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGF220JY02L	AC250 (r.m.s.)	SL (JIS)	22 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342A1XGF270JW31L	AC250 (r.m.s.)	SL (JIS)	27 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGF330JW31L	AC250 (r.m.s.)	SL (JIS)	33 ±5%	4.5	2.0	1.0	2.5	0.3 min. 0.3 min.
GA342A1XGF390JW31L	AC250 (r.m.s.)	SL (JIS)	39 ±5%	4.5	2.0	1.0	2.5	
GA342A1XGF470JW31L	AC250 (r.m.s.)	SL (JIS)	47 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGF560JW31L	AC250 (r.m.s.)	SL (JIS)	56 ±5%	4.5	2.0	1.0 1.0 1.0	2.5	0.3 min. 0.3 min. 0.3 min.
GA342A1XGF680JW31L	AC250 (r.m.s.)	SL (JIS)	68 ±5%	4.5 2.0 4.5 2.0	2.0		2.5	
GA342A1XGF820JW31L	AC250 (r.m.s.)	SL (JIS)	82 ±5%		2.0		2.5	
GA342QR7GF101KW01L	AC250 (r.m.s.)	X7R (EIA)	100 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342QR7GF151KW01L	AC250 (r.m.s.)	X7R (EIA)	150 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342DR7GF221KW02L	AC250 (r.m.s.)	X7R (EIA)	220 ±10%	4.5	2.0	2.0	2.5	0.3 min.
GA342DR7GF331KW02L	AC250 (r.m.s.)	X7R (EIA)	330 ±10%	4.5	2.0	2.0	2.5	0.3 min.
GA342QR7GF471KW01L	AC250 (r.m.s.)	X7R (EIA)	470 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA352QR7GF471KW01L	AC250 (r.m.s.)	X7R (EIA)	470 ±10%	5.7	2.8	1.5	4.0	0.3 min.
GA342QR7GF681KW01L	AC250 (r.m.s.)	X7R (EIA)	680 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA352QR7GF681KW01L	AC250 (r.m.s.)	X7R (EIA)	680 ±10%	5.7	2.8	1.5	4.0	0.3 min.
GA342DR7GF102KW02L	AC250 (r.m.s.)	X7R (EIA)	1000 ±10%	4.5	2.0	2.0	2.5	0.3 min.
GA352QR7GF102KW01L	AC250 (r.m.s.)	X7R (EIA)	1000 ±10%	5.7	2.8	1.5	4.0	0.3 min.



Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GA352QR7GF152KW01L	AC250 (r.m.s.)	X7R (EIA)	1500 ±10%	5.7	2.8	1.5	4.0	0.3 min.
GA355QR7GF182KW01L	AC250 (r.m.s.) X7R (EIA)		1800 ±10%	5.7	5.0	1.5	4.0	0.3 min.
GA355QR7GF222KW01L	AC250 (r.m.s.)	X7R (EIA)	2200 ±10%	5.7	5.0	1.5	4.0	0.3 min.
GA355QR7GF332KW01L	AC250 (r.m.s.)	X7R (EIA)	3300 ±10%	5.7	5.0	1.5	4.0	0.3 min.
GA355DR7GF472KW01L	AC250 (r.m.s.)	X7R (EIA)	4700 ±10%	5.7	5.0	2.0	4.0	0.3 min.

For General Purpose GRM/GRJ Series

Only for Applications

AC250V Type GA2 Series

Safety Standard Certified GA3 Series

Safety Standard Certified GA3 Series

Chip Monolithic Ceramic Capacitors



Safety Standard Certified GA3 Series IEC60384-14 Class Y3 Type GD

■ Features

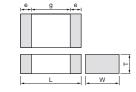
- 1. Available for equipment based on IEC/EN60950 and UL1950.
- 2. Type GD can be used as a Y3-class capacitor.
- 3. A new monolithic structure for small, high capacitance capable of operating at high voltage
- 4. +125 degree C guaranteed
- 5. Only for reflow soldering

Applications

- 1. Ideal for use on line filters and couplings for DAA modems without transformers
- 2. Ideal for use on line filters for information equipment

Do not use these products in any Automotive Power train or Safety equipment including Battery chargers for Electric Vehicles and Plug-in Hybrids. Only Murata products clearly stipulated as "for Automotive use" can be used for automobile applications such as Power train and Safety equipment.





Part Number	Dimensions (mm)							
Part Number	L	L W		e min.	g min.			
GA342A			1.0 +0, -0.3					
GA342D	4.5 ±0.3	2.0 ±0.2	2.0 ±0.2		2.5			
GA342Q			1.5 +0, -0.3	0.3				
GA343D	4.5 +0.4	3.2 +0.3	2.0 +0, -0.3					
GA343Q	4.5 ±0.4	3.2 ±0.3	1.5 +0, -0.3					

■ Standard Certification

	Standard No.	Class	Rated Voltage
UL	UL 60950-1		
SEMKO	IEC 60384-14 EN 60384-14	Y3	AC250V(r.m.s.)

Applications

Size	Switching power supplies	Communication network devices such as a modem
4.5×3.2mm and under	_	0

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GA342D1XGD100JY02L	AC250 (r.m.s.)	SL (JIS)	10 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGD120JY02L	AC250 (r.m.s.)	SL (JIS)	12 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGD150JY02L	AC250 (r.m.s.)	SL (JIS)	15 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGD180JY02L	AC250 (r.m.s.)	SL (JIS)	18 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGD220JY02L	AC250 (r.m.s.)	SL (JIS)	22 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342A1XGD270JW31L	AC250 (r.m.s.)	SL (JIS)	27 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGD330JW31L	AC250 (r.m.s.)	SL (JIS)	33 ±5%	4.5	2.0	1.0 2.5 1.0 2.5 1.0 2.5	2.5	0.3 min.
GA342A1XGD390JW31L	AC250 (r.m.s.)	SL (JIS)	39 ±5%	4.5	2.0		2.5	0.3 min.
GA342A1XGD470JW31L	AC250 (r.m.s.)	SL (JIS)	47 ±5%	4.5	2.0		2.5	0.3 min.
GA342A1XGD560JW31L	AC250 (r.m.s.)	SL (JIS)	56 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGD680JW31L	AC250 (r.m.s.)	SL (JIS)	68 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGD820JW31L	AC250 (r.m.s.)	SL (JIS)	82 ±5%	4.5	2.0	1.0 1.5	2.5	0.3 min.
GA342QR7GD101KW01L	AC250 (r.m.s.)	X7R (EIA)	100 ±10%	4.5	2.0		2.5 2.5	0.3 min. 0.3 min.
GA342QR7GD151KW01L	AC250 (r.m.s.)	X7R (EIA)	150 ±10%	4.5	2.0	1.5		
GA342QR7GD221KW01L	AC250 (r.m.s.)	X7R (EIA)	220 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342QR7GD331KW01L	AC250 (r.m.s.)	X7R (EIA)	330 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342QR7GD471KW01L	AC250 (r.m.s.)	X7R (EIA)	470 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342QR7GD681KW01L	AC250 (r.m.s.)	X7R (EIA)	680 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342QR7GD102KW01L	AC250 (r.m.s.)	X7R (EIA)	1000 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342QR7GD152KW01L	AC250 (r.m.s.)	X7R (EIA)	1500 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA343QR7GD182KW01L	AC250 (r.m.s.)	X7R (EIA)	1800 ±10%	4.5	3.2	1.5	2.5	0.3 min.
GA343QR7GD222KW01L	AC250 (r.m.s.)	X7R (EIA)	2200 ±10%	4.5	3.2	1.5	2.5	0.3 min.
GA343DR7GD472KW01L	AC250 (r.m.s.)	X7R (EIA)	4700 ±10%	4.5	3.2	2.0	2.5	0.3 min.



Chip Monolithic Ceramic Capacitors



Safety Standard Certified GA3 Series IEC60384-14 Class X2 Type GB

■ Features

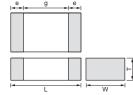
- 1. Type GB can be used as an X2-class capacitor.
- 2. Chip monolithic ceramic capacitor (certified as conforming to safety standards) for AC lines.
- 3. A new monolithic structure for small, high capacitance capable of operating at high voltage
- 4. Compared to lead type capacitors, this new capacitor is greatly downsized and low-profiled to 1/10 or less in volume, and 1/4 or less in height.
- 5. +125 degree C guaranteed
- 6. Only for reflow soldering

■ Applications

Ideal for use as X capacitor for various switching power supplies

Do not use these products in any Automotive Power train or Safety equipment including Battery chargers for Electric Vehicles and Plug-in Hybrids. Only Murata products clearly stipulated as "for Automotive use" can be used for automobile applications such as Power train and Safety equipment.





Dort Number	Dimensions (mm)								
Part Number	L	W	T	e min.	g min.				
GA355Q		1 6 0 +0 4 1	1.5 +0,-0.3		3.0				
GA355D	5.7 ±0.4		2.0 +0,-0.3	1 02					
GA355E	3.7 ±0.4		2.5 +0,-0.3						
GA355X			2.9 +0,-0.4						

■ Standard Certification

	Standard No.	Class	Rated Voltage		
VDE					
SEMKO	IEC 60384-14 EN 60384-14	X2	AC250V (r.m.s.)		
ESTI			, ,		

Part Number	Rated Voltage TC Code Capacitance (V) (Standard) (pF)		Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)	
GA355QR7GB103KW01L	AC250 (r.m.s.)	X7R (EIA)	10000 ±10%	5.7	5.0	1.5	3.0	0.3 min.
GA355QR7GB153KW01L	AC250 (r.m.s.) X7R (EIA) 15000 ±1		15000 ±10%	5.7	5.0	1.5	3.0	0.3 min.
GA355DR7GB223KW01L	AC250 (r.m.s.)	C250 (r.m.s.) X7R (EIA) 22000 ±1		5.7	5.0	2.0	3.0	0.3 min.
GA355ER7GB333KW01L	L AC250 (r.m.s.) X7R (EIA)		33000 ±10%	5.7	5.0	2.5	3.0	0.3 min.
GA355ER7GB473KW01L	AC250 (r.m.s.)	X7R (EIA)	47000 ±10%	5.7	5.0	2.5	3.0	0.3 min.
GA355XR7GB563KW06L	AC250 (r.m.s.)	X7R (EIA)	56000 ±10%	5.7	5.0	2.9	3.0	0.3 min.

GA3 Series Specifications and Test Methods

No.	Ite	em	Specifications	Test Method		
1	Operating Temperatu	ure Range	-55 to +125℃	-		
2	Appearar	nce	No defects or abnormalities	Visual inspection		
3	Dimensio	ns	Within the specified dimensions	Using calipers and micrometers		
4	Dielectric	: Strength	No defects or abnormalities	No failure should be observed when voltage in the table is applied between the terminations for 60±1 sec., provided the charge/discharge current is less than 50mA. Test Voltage		
				Type GB DC1075V Type GC/GD AC1500V (r.m.s.) Type GF AC2000V (r.m.s.)		
5	Pulse Vol (Applicati GD/GF)		No self healing breakdowns or flash-overs have taken place in the capacitor.	10 impulses of alternating polarity are subjected. (5 impulses for each polarity) The interval between impulses is 60 sec. Applied Pulse: 1.2/50μs Applied Voltage: 2.5kVo-p		
6	Insulation F (I.R.)	Resistance	More than $6{,}000M\Omega$	The insulation resistance should be measured with DC500±50V and within 60±5 sec. of charging.		
7	Capacita	nce	Within the specified tolerance			
8	Dissipation 3 Factor (D.F.) Q		Char. Specification X7R D.F.≦0.025 SL Q≥400+20C*² (C<30pF)	The capacitance/Q/D.F. should be measured at a frequency of 1±0.2kHz (SL char.: 1±0.2MHz) and a voltage of AC1±0.2V (r.m.s.)		
9	Temperat	Char. Capacitance Change X7R Within ±15% Temperature characteristic guarantee is −55 to +125°C Char. Temperature Coefficient SL +350 to −1000ppm/°C Temperature characteristic guarantee is +20 to +85°C		The capacitance measurement should be made at each step specified in the Table. Step Temperature (°C) 1 25±2 (20±2 for SL char.) 2 Min. Operating Temp.±3 3 25±2 (20±2 for SL char.) 4 Max. Operating Temp.±2 5 25±2 (20±2 for SL char.) SL char.: The capacitance should be measured at even 85°C between step 3 and step 4. • Pretreatment for X7R char. Perform a heat treatment at 150±18°C for 60±5 min. and then let sit for 24±2 hrs. at room condition.*1		
		Appearance	No defects or abnormalities	As in Fig., discharge is made 50 times at 5 sec. intervals from		
		I.R.	More than 1,000MΩ	the capacitor (Cd) charged at DC voltage of specified.		
10	Discharge Test (Application: Type GC)	Dielectric Strength	In accordance with item No.4	R3 R1		
11	Adhesive Strength of Termination		No removal of the terminations or other defect should occur.	R1: 1,000\(\Omega\) R2: 100M\(\Omega\) R3: Surge resistance Solder the capacitor to the testing jig (glass epoxy board) shown in Fig. 1. Then apply 10N force in the direction of the arrow. The solderin should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.		

^{*1 &}quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa





^{*2 &}quot;C" expresses nominal capacitance value (pF).

GA3 Series Specifications and Test Methods

\nearrow	Continued from the pred	eding page.

	g orininea non-ine precent g page.									
No.	Ite	em		S	pecification	s			Test Method	
12	Vibration Resistance	Appearance No defects or abnormalities Capacitance Within the specified tolerance D.F. Specification X7R D.F.≤0.025 Q≥400+20C*² (C<30pF) Q≥1000 (C≥30pF)				The capacitor having a total uniformly between traversed in a		nple harmonic motion quency being varied of 10 and 55Hz. The urn to 10Hz, should be tion should be applied		
13	Deflection	1	LXW (mm) 4.5x2.0 4.5x3.2 5.7x5.0	a 3.5 3.5 4.5 4.5	100 Fig. 2	04.5 t:1.6 ion (mm) C 2.4 3.7 3.2 5.6	d - 1.0	in Fig. 2. Then apply a should be dor conducted wi	pacitor to the testing jig (glass force in the direction shown in the using the reflow method at the care so that the soldering as heat shock. 20 50 Pressurizing speed: 1.0r Pressurize Pressurize Flexur 45 Fig. 3	n Fig. 3. The soldering and should be is uniform and free of
14	Solderability of				d continuously.	rosin (JIS-K-5 Immerse in so Immersing sp Temp. of solo	capacitor in a solution of eth: 1902) (25% rosin in weight probler solution for 2±0.5 sec. 1904: 25±2.5mm/s 1905: 245±5°C Lead Free Solution 235±5°C H60A or H63A	der (Sn-3.0Ag-0.5Cu) Eutectic Solder		
15	Resistance to Soldering Heat	Capacitance Change	(\	Capacitano Within : Vithin ±2.5% Whichever is	±10% or ±0.25pF	-		Preheat the capacitor as in table. Immerse the capacitor in solder solution at 260±5℃ for 10±1 sec. Let sit at room condition*1 for 24±2 hrs., then measure. •Immersing speed: 25±2.5mm/s •Pretreatment for X7R char. Perform a heat treatment at 150 [±] 10°℃ for 60±5 min. and then let sit for 24±2 hrs. at room condition.*1		
		Dielectric Strength	More than 1,000M Ω In accordance with item No.4					*Preheating Step Temperature Time 1 100 to 120°C 1 min.		

^{*1 &}quot;Room condition" Temperature: 15 to 35℃, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

Continued on the following page.

1 min.





2

170 to 200℃

^{*2 &}quot;C" expresses nominal capacitance value (pF).

AC250V Type GA2 Series

GA3 Series Specifications and Test Methods

Continued from the preceding page.

No.	o. Item		Specifications	Test Method		
		Appearance No marking defects Capacitance Char. Capacitance Change Change X7R Within ±15% SL Within ±2.5% or ±0.25pF (Whichever is larger)		Fix the capacitor to the supporting jig (glass epoxy board) shown in Fig. 4. Perform the 5 cycles according to the 4 heat treatments listed in the following table. Let sit for 24±2 hrs. at room condition,*1 then measure.		
	Temperature	D.F. Q	Char. Specification X7R D.F.≤0.05 SL Q≥400+20C*² (C<30pF)	Step Temperature (℃) Time (min.) 1 Min. Operating Temp.±3 30±3 2 Room Temp. 2 to 3 3 Max. Operating Temp.±2 30±3 4 Room Temp. 2 to 3		
16	Cycle	I.R.	More than $3{,}000\text{M}\Omega$	Pretreatment for X7R char. Performs be at the attraction and the second s		
		Dielectric Strength	In accordance with item No.4	Perform a heat treatment at 150 [±] -18°C for 60±5 min. and the let sit for 24±2 hrs. at room condition.*1		
		Appearance	No marking defects			
		Capacitance Change	Char. Capacitance Change X7R Within ±15% SL Within ±5.0% or ±0.5pF (Whichever is larger)	Before this test, the test shown in the following is performedItem 11 Adhesive Strength of Termination (applied force is 5N) -Item 13 Deflection		
17	Humidity (Steady State)	D.F. Q	Char. Specification X7R D.F.≤0.05 SL Q≥275+5/2C*² (C<30pF)	Let the capacitor sit at 40±2°C and relative humidity of 90 to for 500 ^{±2} 6 hrs. Remove and let sit for 24±2 hrs. at room condition,*1 then measure. •Pretreatment for X7R char.		
		I.R.	More than $3{,}000\text{M}\Omega$	Perform a heat treatment at 150 [±] ₁8°C for 60±5 min. and then let sit for 24±2 hrs. at room condition.*¹		
		Dielectric Strength	In accordance with item No.4			
		Appearance	No marking defects	Before this test, the test shown in the following is performed.		
		Capacitance X7F Change SL	Char. Capacitance Change X7R Within ±20% SL Within ±3.0% or ±0.3pF (Whichever is larger) Char. Specification	-Item 11 Adhesive Strength of Termination (apply force is 5N) -Item 13 Deflection Impulse Voltage Each individual capacitor should be subjected to a 2.5kV (Type CO(ΣΕΕΚΑΝ) Impulse (Hz)		
		D.F. Q	X7R D.F.≤0.05 SL Q≥275+5/2C*2 (C<30pF) Q≥350 (C≥30pF)	voltage value means zero to peak) for three times. Then the capacitors are applied to life test.		
18	Life	I.R.	More than 3,000MΩ	Apply voltage as in Table for 1,000 hrs. at 125 ⁺² ₋₀ °C, relative humidity 50% max.		
		Dielectric Strength	In accordance with item No.4	Type Applied Voltage GB AC312.5V (r.m.s.), except that once each hour the voltage is increased to AC1,000V (r.m.s.) for 0.1 sec. GC GF AC425V (r.m.s.), except that once each hour the voltage is increased to AC1,000V (r.m.s.) for 0.1 sec. Let sit for 24±2 hrs. at room condition,*¹ then measure. •Pretreatment for X7R char. Perform a heat treatment at 150±16° c for 60±5 min. and then let sit for 24±2 hrs. at room condition.*¹		

^{*1 &}quot;Room condition" Temperature: 15 to 35℃, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa





^{*2 &}quot;C" expresses nominal capacitance value (pF).

GA3 Series Specifications and Test Methods

☐ Continued from	the preceding page	Э.
<u> </u>	the proceding page	-

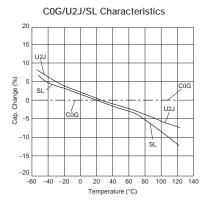
No.	Ite	em	Specifications	Test Method
		Appearance	No marking defects	
	Capacitance Change		Char. Capacitance Change X7R Within ±15% SL Within ±5.0% or ±0.5pF (Whichever is larger)	Before this test, the test shown in the following is performedItem 11 Adhesive Strength of Termination (apply force is 5N) -Item 13 Deflection
19	Humidity Loading	D.F. Q	Char. Specification X7R D.F.≤0.05 SL Q≥275+5/2C*² (C<30pF)	Apply the rated voltage at 40±2°C and relative humidity of 90 to 95% for 500±2°c hrs. Remove and let sit for 24±2 hrs. at room condition,*1 then measure. • Pretreatment for X7R char. Perform a heat treatment at 150±1° °C for 60±5 min. and then
		I.R.	More than $3{,}000$ M Ω	let sit for 24±2 hrs. at room condition.*1
		Dielectric Strength	In accordance with item No.4	
20	Active		The cheesecloth should not be on fire.	The capacitor should be individually wrapped in at least one but not more than two complete layers of cheesecloth. The capacitor should be subjected to 20 discharges. The interval between successive discharges should be 5 sec. The UAc should be maintained for 2 min. after the last discharge. C1,2 : 1μF±10%
21	Passive Flammability		The burning time should not exceed 30 sec. The tissue paper should not ignite.	The capacitor under test should be held in the flame in the position which best promotes burning. Each specimen should be exposed to the flame only once. Time of exposure to flame: 30 sec. Length of flame: 12±1mm Gas burner : Length 35mm min. Inside Dia. 0.5±0.1mm Outside Dia. 0.9mm max. Gas : Butane gas Purity 95% min. Test Specimen Tissue About 10mm Thick Board

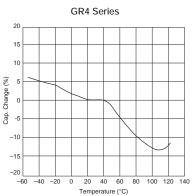
^{*1 &}quot;Room condition" Temperature: 15 to 35℃, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

 $^{^{*}2}$ "C" expresses nominal capacitance value (pF).

GRM/GRJ/GR4/GR7/GA2/GA3 Series Reference Data (Typical Example)

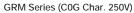
■ Capacitance - Temperature Characteristics

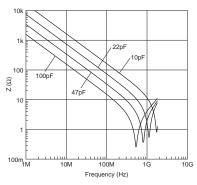


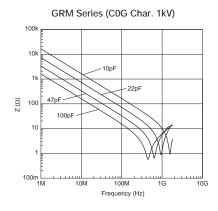


X7R Characteristics X7R Char. Spec.(upper) Change (%) Cap. -20 20 40 60 80 100 120 140 -60 -40 0 Temperature (°C)

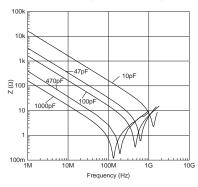
■ Impedance - Frequency Characteristics



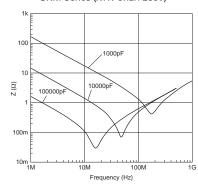




GRM Series (C0G Char. 630V)



GRM Series (X7R Char. 250V)





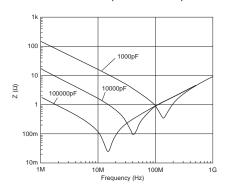


GRM/GRJ/GR4/GR7/GA2/GA3 Series Reference Data (Typical Example)

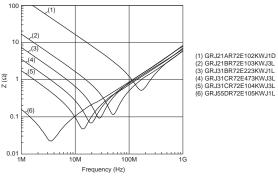
Continued from the preceding page.

■ Impedance - Frequency Characteristics

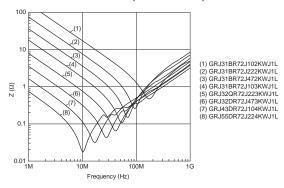
GRM Series (X7R Char. 630V)



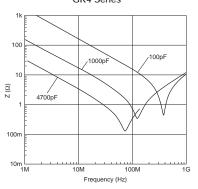
GRJ Series (X7R Char. 250V)



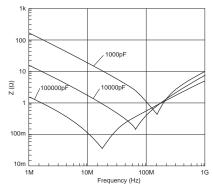
GRJ Series (X7R Char. 630V)



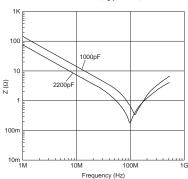
GR4 Series



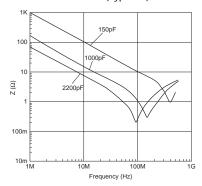
GA2 Series



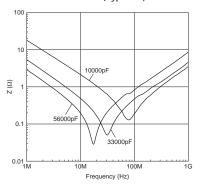
GA3 Series (Type GF)



GA3 Series (Type GD)



GA3 Series (Type GB)



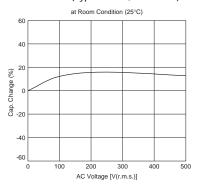


GRM/GRJ/GR4/GR7/GA2/GA3 Series Reference Data (Typical Example)

Continued from the preceding page.

■ Capacitance - AC Voltage Characteristics

GA3 Series (Type GF/GD, X7R Char.)



at Room Condition (25°C) 40 Change (%) 10000pF 33000pF Cap. 56000pl

400

600

AC Voltage [V(r.m.s.)]

800

1000

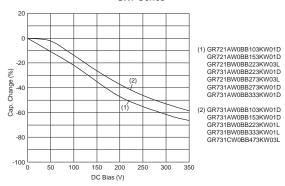
-60 L

200

GA3 Series (Type GB)

■ Capacitance - DC Bias Characteristics

GR7 Series



Package

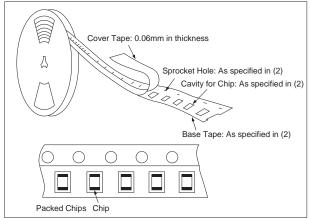
Taping is the standard packaging method.

■ Minimum Quantity Guide

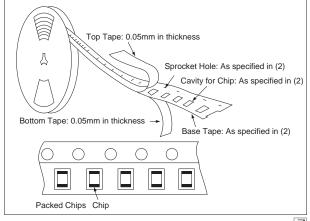
		Dimensions (mm)			Quantity (pcs.)		
	Part Number	Zimonolone (miny		ø180mm Reel			
			W	Т	Paper Tape	Embossed Tape	
	GRM18	1.6	0.8	0.8	4,000	-	
	OD 104/ODM04/OD704	0.0	4.05	1.0	4,000	-	
	GRJ21/GRM21/GR721	2.0	1.25	1.25	-	3,000	
				1.0	4,000	-	
	GRJ31/GRM31/GR731	3.2	1.6	1.25	-	3,000	
				1.6	-	2,000	
				1.0	4,000	-	
Medium			2.5	1.25	-	3,000	
Voltage	GRJ32/GRM32	3.2		1.5	-	2,000	
				2.0	-	1,000	
			2.0	1.0	-	3,000	
	GRM42/GR442	4.5		1.5	-	2,000	
				1.5	-	1,000	
	GRJ43/GRM43/GR443	4.5		2.0	-	1,000	
				2.5	- 1,000 - 500 - 1,000		
	GRJ55/GRM55/GR455	5.7	5.0	2.0	-	1,000	
	GA242	4.5	2.0	1.5	-	2,000	
4.00501/		4.5	3.2	1.5	-	1,000	
AC250V	GA243			2.0	-	1,000	
	GA255	5.7	5.0	2.0	-	1,000	
				1.0	-	3,000	
	GA342	4.5	2.0	1.5	-	2,000	
				2.0	-	2,000	
	04040	4.5	0.0	1.5	-	1,000	
	GA343	4.5	3.2	2.0	-	1,000	
Safety Std. ertification	GA352	5.7	2.8	1.5	-	1,000	
ei iiiicati0I1				1.5	-	1,000	
				2.0	-	1,000	
	GA355	5.7	5.0	2.5	-	500	
				2.7	-	500	
				2.9	-	500	

■ Tape Carrier Packaging

- (1) Appearance of Taping
- ① Embossed Tape





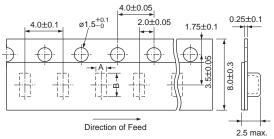




Package

- Continued from the preceding page.
- (2) Dimensions of Tape
- 1 Embossed Tape

8mm width, 4mm pitch Tape



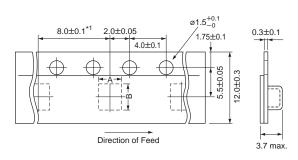
		2.6
Part Number	A*	B*
GRJ21/GRM21/GR721 (T≧1.25mm)	1.45	2.25
GRJ31/GRM31/GR731 (T≧1.25mm)	2.0	3.6
GRJ32/GRM32		

2.9

*Nominal Value

3.6

12mm width, 8mm/4mm pitch Tape



Part Number	A*	B*
GRM42/GR442/GA242/GA342	2.5	5.1
GRJ43/GRM43/GR443/GA243/GA343	3.6	4.9
GA352	3.2	6.1
GRJ55/GRM55/GR455/GA255/GA355	5.4	6.1

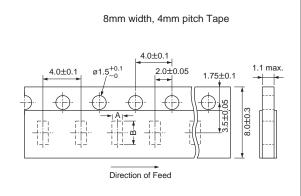
^{*1 4.0±0.1}mm in case of GRM42/GR442/GA242/GA342

*Nominal Value

(in mm)

2 Paper Tape

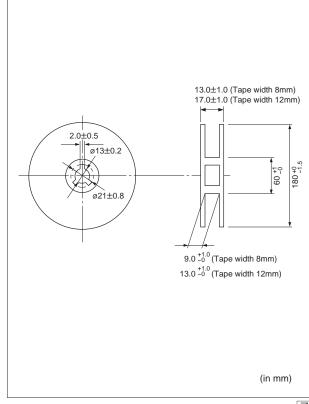
(T≧1.25mm)



Part Number	A*	B*
GRM18	1.05	1.85
GRJ21/GRM21/GR721 (T=1.0mm)	1.45	2.25
GRM31/GR731 (T=1.0mm)	2.0	3.6
GRM32 (T=1.0mm)	2.9	3.6

*Nominal Value (in mm)

(3) Dimensions of Reel





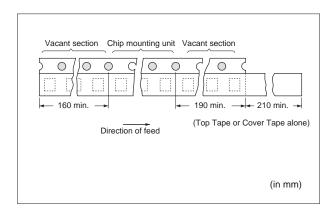


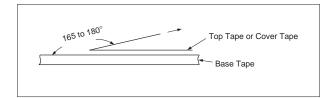
Package

Continued from the preceding page.

(4) Taping Method

- 1) Tapes for capacitors are wound clockwise. The sprocket holes are to the right as the tape is pulled toward the user.
- 2 Part of the leader and part of the empty tape should be attached to the end of the tape as shown at right.
- 3 The top tape or cover tape and base tape are not attached at the end of the tape for a minimum of 5 pitches.
- 4 Missing capacitors number within 0.1% of the number per reel or 1 pc, whichever is greater, and are not continuous.
- 5 The top tape or cover tape and bottom tape should not protrude beyond the edges of the tape and should not cover sprocket holes.
- 6 Cumulative tolerance of sprocket holes, 10 pitches: ±0.3mm.
- 7 Peeling off force: 0.1 to 0.6N in the direction shown at right.





⚠Caution

■ Storage and Operating Conditions

Operating and storage environment

Do not use or store capacitors in a corrosive atmosphere, especially where chloride gas, sulfide gas, acid, alkali, salt or the like are present. In addition, avoid exposure to moisture. Before cleaning, bonding or molding this product, verify that these processes do not affect product quality by testing the performance of a cleaned, bonded or molded product in the intended equipment. Store the capacitors where the temperature and relative humidity do not exceed 5 to 40 degrees centigrade and 20 to 70%.

Use capacitors within 6 months of delivery. Check the solderability after 6 months or more.

FAILURE TO FOLLOW THE ABOVE CAUTIONS MAY RESULT, WORST CASE, IN A SHORT CIRCUIT AND CAUSE FUMING OR PARTIAL DISPERSION WHEN THE PRODUCT IS USED.

Handling

- 1. Vibration and impact Do not expose a capacitor to excessive shock or vibration during use.
- 2. Do not directly touch the chip capacitor, especially the ceramic body. Residue from hands/fingers may create a short circuit environment.

FAILURE TO FOLLOW THE ABOVE CAUTIONS MAY RESULT, WORST CASE, IN A SHORT CIRCUIT AND CAUSE FUMING OR PARTIAL DISPERSION WHEN THE PRODUCT IS USED.



Caution (Rating)

1. Operating Voltage

When DC-rated capacitors are to be used in AC or ripple current circuits, be sure to maintain the Vp-p value of the applied voltage or the Vo-p which contains DC bias within the rated voltage range.

When the voltage is applied to the circuit, starting or stopping may generate irregular voltage for a transit period because of resonance or switching. Be sure to use a capacitor with a rated voltage range that includes these irregular voltages.

When DC-rated capacitors are to be used in input circuits from a commercial power source (AC filter), be sure to use Safety Certified Capacitors because various regulations for withstanding voltage or impulses, established for all equipment, should be taken into consideration.

Voltage	DC Voltage	DC+AC Voltage	AC Voltage	Pulse Voltage (1)	Pulse Voltage (2)
Positional Measurement	Vo-p	Vo-p	Vp-p	Vp-p	Vp-p

- 2. Operating Temperature, Self-generated Heat, and Load Reduction at High-frequency Voltage Condition Keep the surface temperature of a capacitor below the upper limit of its rated operating temperature range. Be sure to take into account the heat generated by the capacitor itself. When the capacitor is used in a highfrequency voltage, pulse voltage, it may self-generate heat due to dielectric loss.
- Applied voltage should be the load such as selfgenerated heat is within 20°C on the condition of atmosphere temperature 25°C. When measuring, use a thermocouple of small thermal capacity -K of Ø0.1mm in conditions where the capacitor is not affected by radiant heat from other components or surrounding ambient fluctuations. Excessive heat may lead to deterioration of the capacitor's characteristics and reliability. (Never attempt to perform measurement with the cooling fan running. Otherwise, accurate

measurement cannot be ensured.)

(1) In the case of X7R char.

Continued on the following page. $| \overline{\ \ } |$





Continued from the preceding page.

(2) In case of COG, U2J char.

Due to the low self-heating characteristics of lowdissipation capacitors, the allowable electric power of these capacitors is generally much higher than that of X7R characteristic capacitors.

When a high frequency voltage that causes 20°C selfheating to the capacitor is applied, it will exceed the capacitor's allowable electric power.

The frequency of the applied sine wave voltage should be less than 500kHz (less than 100kHz in the case of rated voltage: DC3.15kV). The applied voltage should be less than the value shown in figure below.

In the case of non-sine wave that includes a harmonic frequency, please contact our sales representatives or product engineers. Excessive heat may lead to deterioration of the capacitor's characteristics and reliability. (Never attempt to perform measurement with the cooling fan running. Otherwise, accurate measurement cannot be ensured.)

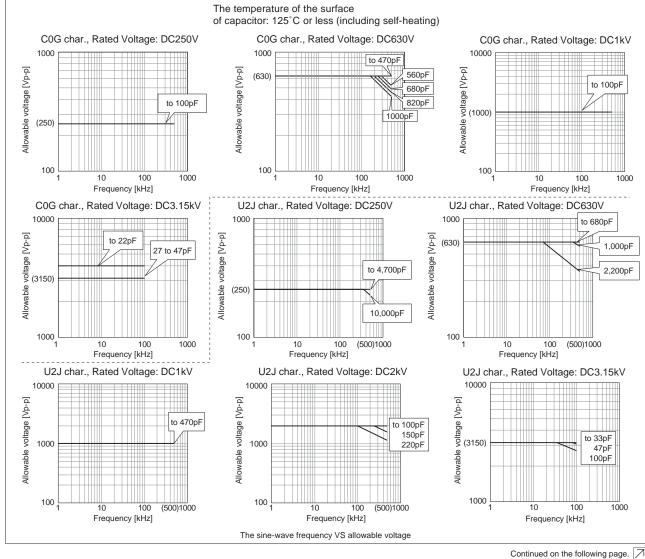
<C0G char., Rated Voltage: DC3.15kV>

The capacitors less than 22pF can be applied maximum 4.0kV peak to peak at 100kHz or less only for the ballast or the resonance usage in the LCD backlight inverter circuit.

<Capacitor Selection Tool>

We are also offering free software/the capacitor selection tool: "Murata Medium Voltage Capacitors Selection Tool by Voltage Form," which will assist you in selecting a suitable capacitor.

The software can be downloaded from Murata's Website. (http://www.murata.com/designlib/mmcsv/index.html). By inputting capacitance values and the applied voltage waveform of the specific capacitor series, this software will calculate the capacitor's power consumption and list suitable capacitors (non-sine wave is also available).





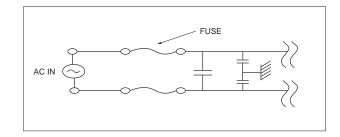


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3. Fail-safe

Failure of a capacitor may result in a short circuit. Be sure to provide an appropriate fail-safe function such as a fuse on your product to help eliminate possible electric shock, fire, or fumes.

Please consider using fuses on each AC line if the capacitors are used between the AC input lines and earth (line bypass capacitors), to prepare for the worst case, such as a short circuit.



4. Test Condition for AC Withstanding Voltage

(1) Test Equipment

Tests for AC withstanding voltage should be made with equipment capable of creating a wave similar to a 50/60 Hz sine wave.

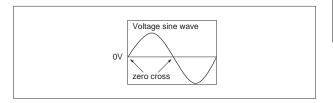
If the distorted sine wave or overload exceeding the specified voltage value is applied, a defect may be caused.

(2) Voltage Applied Method

The capacitor's leads or terminals should be firmly connected to the output of the withstanding voltage test equipment, and then the voltage should be raised from near zero to the test voltage. If the test voltage is applied directly to the capacitor without raising it from near zero, it should be applied with the zero cross.* At the end of the test time, the test voltage should be reduced to near zero, and then the capacitor's leads or terminals should be taken off the output of the withstanding voltage test equipment. If the test voltage is applied directly to the capacitor without raising it from near zero, surge voltage may occur and cause a defect.

- *ZERO CROSS is the point where voltage sine wave passes 0V.
- See the figure at right -

FAILURE TO FOLLOW THE ABOVE CAUTIONS MAY RESULT, WORST CASE, IN A SHORT CIRCUIT AND CAUSE FUMING OR PARTIAL DISPERSION WHEN THE PRODUCT IS USED.





1Caution

Caution (Soldering and Mounting)

1. Vibration and Impact Do not expose a capacitor to excessive shock or vibration during use.

of improvement>

2. Circuit Board Material

It is possible for the chip to crack by the expansion and shrinkage of a metal board.

Please contact us if you want to use our ceramic capacitors on a metal board such as Aluminum.

3. Land Layout for Cropping PC Board

Choose a mounting position that minimizes the stress imposed on the chip during flexing or bending of the board.

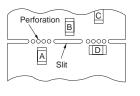
[Component Direction]

to be avoided>

<Example <Example

Locate chip horizontal to the direction in which stress acts.

[Chip Mounting Close to Board Separation Point]



Chip arrangement Worst A>C>B~D Best



∆Caution

Continued from the preceding page.

4. Reflow Soldering

- When components are exposed to sudden heat, their mechanical strength can be decreased due to the extreme temperature changes which can cause flexing and result in internal mechanical damage, which will cause the parts to fail. In order to prevent mechanical damage, preheating is required for both the components and the PCB board. Preheating conditions are shown in Table 1. It is required to keep the temperature differential between the soldering and the components surface (ΔT) as small as possible.
- Solderability of Tin plating termination chips might be deteriorated when low temperature soldering profile where peak solder temperature is below the Tin melting point is used. Please confirm the solderability of Tin plating termination chips before use.
- When components are immersed in solvent after mounting, be sure to maintain the temperature difference (ΔT) between the component and solvent within the range shown in the Table 1.

Table 1

Part Number	Temperature Differential	
G□□18/21/31	ΔΤ≦190℃	
G 32/42/43/52/55	ΔΤ≦130℃	

Recommended Conditions

	Pb-Sn S	Lead Free Solder	
	Infrared Reflow	Vapor Reflow	Lead Free Solder
Peak Temperature	230-250°C	230-240°C	240-260°C
Atmosphere	Air	Air	Air or N2

Pb-Sn Solder: Sn-37Pb Lead Free Solder: Sn-3.0Ag-0.5Cu

Optimum Solder Amount for Reflow Soldering

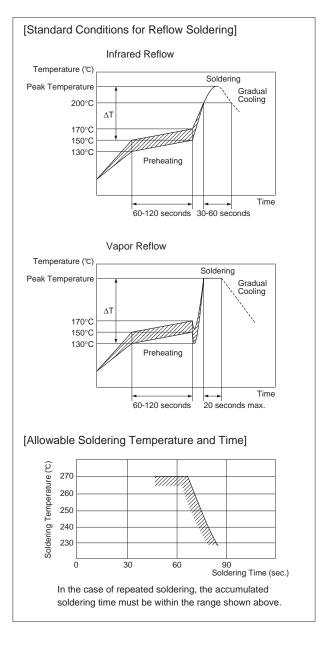
 Overly thick application of solder paste results in excessive solder fillet height.

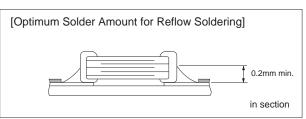
This makes the chip more susceptible to mechanical and thermal stress on the board and may cause cracked chips.

- Too little solder paste results in a lack of adhesive strength on the outer electrode, which may result in chips breaking loose from the PCB.
- Make sure the solder has been applied smoothly to the end surface to a height of 0.2mm min.

Inverting the PCB

Make sure not to impose an abnormal mechanical shock on the PCB.





Continued from the preceding page.

5. Flow Soldering

- When components are exposed to sudden heat, their mechanical strength can be decreased due to the extreme temperature changes which can cause flexing and result in internal mechanical damage, which will cause the parts to fail. Additionally, an excessively long soldering time or high soldering temperature results in leaching by the outer electrodes, causing poor adhesion or a reduction in capacitance value due to loss of contact between electrodes and end termination.
- In order to prevent mechanical damage, preheating is required for both the components and the PCB board. Preheating conditions are shown in Table 2. It is required to keep temperature differential between the soldering and the components surface (ΔT) as small as possible.
- When components are immersed in solvent after mounting, be sure to maintain the temperature difference between the component and solvent within the range shown in Table 2.

Do not apply flow soldering to chips not listed in Table 2.

Table 2

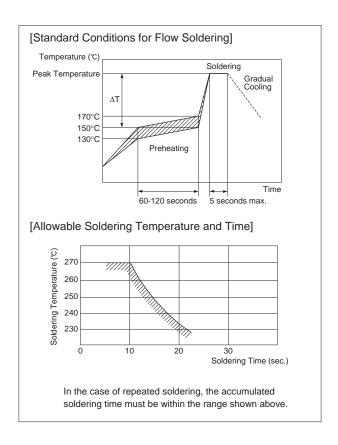
Part Number	Temperature Differential	
G□□18/21/31	ΔT≦150°C	

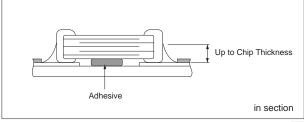
Recommended Conditions

	Pb-Sn Solder	Lead Free Solder
Peak Temperature	240-250°C	250-260°C
Atmosphere	Air	N ₂

Pb-Sn Solder: Sn-37Pb Lead Free Solder: Sn-3.0Ag-0.5Cu

 Optimum Solder Amount for Flow Soldering The top of the solder fillet should be lower than the thickness of components. If the solder amount is excessively large, the risk of cracking is higher during board bending or under any other stressful conditions.









⚠Caution

Continued from the preceding page.

6. Correction with a Soldering Iron

 When sudden heat is applied to the components by use of a soldering iron, the mechanical strength of the components will decrease because the extreme temperature change causes deformations inside the components.

In order to prevent mechanical damage to the components, preheating is required for both the components and the PCB board.

Preheating conditions, (The "Temperature of the Soldering Iron Tip", "Preheating Temperature,"

"Temperature Differential" between iron tip and the

Table 3

Part Number	Temperature of Soldering Iron tip	Preheating Temperature	Temperature Differential (∆T)	Atmosphere
G□□18/21/31	350°C max.	150°C min.	ΔΤ≦190℃	air
G□□32/42/43/ 52/55	280°C max.	150°C min.	ΔΤ≦130℃	air

^{*}Applicable for both Pb-Sn and Lead Free Solder.

Pb-Sn Solder: Sn-37Pb

Lead Free Solder: Sn-3.0Ag-0.5Cu

 Optimum Solder Amount when re-working Using a Soldering Iron

For sizes smaller than G = 18, the top of the solder fillet should be lower than 2/3 of the thickness of the component or 0.5mm whichever is smaller.

For sizes larger than $G \square \square 21$, the top of the solder fillet should be lower than 2/3 of the thickness of the component.

If the solder amount is excessive, the risk of cracking is higher during board bending or under any other stressful

A Soldering iron ø3mm or smaller should be used. It is also necessary to keep the soldering iron from touching the components during the re-work. Solder wire with Ø0.5mm or smaller is required for soldering.

7. Washing

Excessive output of ultrasonic oscillation during cleaning causes PCBs to resonate, resulting in cracked chips or broken solder. Take note not to vibrate PCBs.

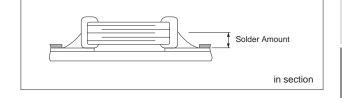
FAILURE TO FOLLOW THE ABOVE CAUTIONS MAY RESULT, WORST CASE, IN A SHORT CIRCUIT AND FUMING WHEN THE PRODUCT IS USED.

components and the PCB), should be within the conditions of table 3.

It is required to keep the temperature differential between the soldering Iron and the component's surface (ΔT) as small as possible.

After soldering, do not allow the component/PCB to cool down rapidly.

The operating time for the re-working should be as short as possible. When re-working time is too long, it may cause solder leaching, in turn causing a reduction of the adhesive strength of the terminations.



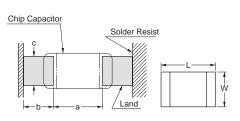
Notice

■ Notice (Soldering and Mounting)

1. Construction of Board Pattern

After installing chips, if solder is excessively applied to the circuit board, mechanical stress will cause destruction resistance characteristics to lower. To prevent this, be extremely careful in determining shape and dimension before designing the circuit board diagram.

Construction and Dimensions of Pattern (Example)



Flow Soldering

L×W	а	b	С
1.6×0.8	0.6-1.0	0.8-0.9	0.6-0.8
2.0×1.25	1.0-1.2	0.9-1.0	0.8-1.1
3.2×1.6	2.2-2.6	1.0-1.1	1.0-1.4

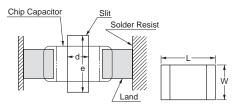
Flow soldering: 3.2×1.6 or less available.

Reflow Soldering

TKOHOW OOK	icinig		
L×W	а	b	С
1.6×0.8	0.6-0.8	0.6-0.7	0.6-0.8
2.0×1.25	1.0-1.2	0.6-0.7	0.8-1.1
3.2×1.6	2.2-2.4	0.8-0.9	1.0-1.4
3.2×2.5	2.0-2.4	1.0-1.2	1.8-2.3
4.5×2.0	2.8-3.4	1.2-1.4	1.4-1.8
4.5×3.2	2.8-3.4	1.2-1.4	2.3-3.0
5.7×2.8	4.0-4.6	1.4-1.6	2.1-2.6
5.7×5.0	4.0-4.6	1.4-1.6	3.5-4.8

(in mm)

Dimensions of Slit (Example)



Preparing the slit helps flux cleaning and resin coating on the back of the capacitor. However, the length of the slit design should be as short as possible to prevent mechanical

A longer slit design might receive more severe mechanical stress from the PCB.

Recommended slit design is shown in the Table.

damage in the capacitor.

L×W	d	е
1.6×0.8	-	-
2.0×1.25	-	-
3.2×1.6	1.0-2.0	3.2-3.7
3.2×2.5	1.0-2.0	4.1-4.6
4.5×2.0	1.0-2.8	3.6-4.1
4.5×3.2	1.0-2.8	4.8-5.3
5.7×2.8	1.0-4.0	4.4-4.9
5.7×5.0	1.0-4.0	6.6-7.1

(in mm)

Continued on the following page. $\begin{tabular}{|c|c|c|c|c|c|} \hline \end{tabular}$





Notice

Continued from the preceding page.

Land Layout to Prevent Excessive Solder

	Mounting Close to a Chassis	Mounting with Leaded Components	Mounting Leaded Components Later
Examples to Be Avoided	Chassis Solder (Ground solder) Adhesive Base board Land Pattern in section	Lead Wire Connected to a Part Provided with Lead Wires.	Soldering Iron Lead Wire of Component to be Connected Later. in section
Examples of Improvements by the Land Division	d2 d1 <d2 resist<="" solder="" td=""><td>Solder Resist</td><td>Solder Resist</td></d2>	Solder Resist	Solder Resist
	in section	in section	in section

2. Mounting of Chips

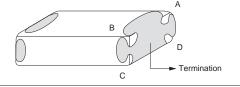
- Thickness of adhesives applied Keep thickness of adhesives applied (50-105µm or more) to reinforce the adhesive contact considering the thickness of the termination or capacitor (20-70 μ m) and the land pattern (30-35µm).
- Mechanical shock of the chip placer When the positioning claws and pick-up nozzle are worn, the load is applied to the chip while positioning is concentrated in one position, thus causing cracks, breakage, faulty positioning accuracy, etc. Careful checking and maintenance are necessary to prevent unexpected trouble. An excessively low bottom dead point of the suction nozzle imposes great force on the chip during mounting, causing cracked chips. Please set the suction nozzle's bottom dead point on the upper surface of the board.

3. Soldering

(1) Limit of losing effective area of the terminations and conditions needed for soldering.

Depending on the conditions of the soldering temperature and/or immersion (melting time), effective areas may be lost in some parts of the

To prevent this, be careful in soldering so that any possible loss of the effective area on the terminations will securely remain at a maximum of 25% on all edge length A-B-C-D-A of part with A, B, C, D, shown in the Figure below.



(2) Flux Application

- An excessive amount of flux generates a large quantity of flux gas, causing deteriorated solderability. So apply flux thinly and evenly throughout. (A foaming system is generally used for flow soldering.)
- Flux containing too high a percentage of halide may cause corrosion of the outer electrodes without sufficient cleaning. Use flux with a halide content of 0.2% max.
- Do not use strong acidic flux.
- Do not use water-soluble flux.* (*Water-soluble flux can be defined as non rosin type flux including wash-type flux and non-wash-type flux.)
- (3) Solder

The use of Sn-Zn based solder will deteriorate the reliability of the MLCC.

Please contact our sales representative or product engineers on the use of Sn-Zn based solder in advance.







Certified GA3 Series Safety Standard

Notice

Continued from the preceding page.

4. Cleaning

Please confirm there is no problem in the reliability of the product beforehand when cleaning it with the intended

The residue after cleaning it might cause a decrease in the surface resistance of the chip and the corrosion of the electrode part, etc. As a result it might cause reliability to deteriorate. Please confirm beforehand that there is no problem with the intended equipment in ultrasonic cleansing.

5. Resin Coating

Please use it after confirming there is no influence on the product with the intended equipment before the resin coating and molding.

A cracked chip might be caused at the cooling/heating cycle by the amount of resin spreading and/or bias

The resin for coating and molding must be selected as the stress is small when stiffening and the hygroscopic is low as possible.

Rating

- 1. Capacitance change of capacitor
- (1) In the case of X7R char.

Capacitors have an aging characteristic, whereby the capacitor continually decreases its capacitance slightly if the capacitor is left on for a long time. Moreover, capacitance might change greatly depending on the surrounding temperature or an applied voltage. Therefore, it is not likely to be suitable for use in a time constant circuit.

Please contact us if you need detailed information.

(2) In the case of any char. except X7R Capacitance might change a little depending on the surrounding temperature or an applied voltage. Please contact us if you intend to use this product in a strict time constant circuit.

2. Performance check by equipment

Before using a capacitor, check that there is no problem in the equipment's performance and the specifications.

Generally speaking, CLASS 2 (X7R char.) ceramic capacitors have voltage dependence characteristics and temperature dependence characteristics in capacitance. Therefore, the capacitance value may change depending on the operating condition in the

Accordingly, be sure to confirm the apparatus performance of receiving influence in a capacitance value change of a capacitor, such as leakage current and noise suppression characteristics.

Moreover, check the surge-proof ability of a capacitor in the equipment, if needed, because the surge voltage may exceed the specific value by the inductance of the circuit.



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The products listed here have been produced by ISO 9001 certified factory.

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- ③ DC voltage bias characteristics (Absolute capacitance/change rate)
- 4 Temperature characteristics (Absolute capacitance/change rate)
- (5) AC voltage bias characteristics (Absolute capacitance/change rate)
- 6 Download SPICE netlist/ S parameter

Select the Products

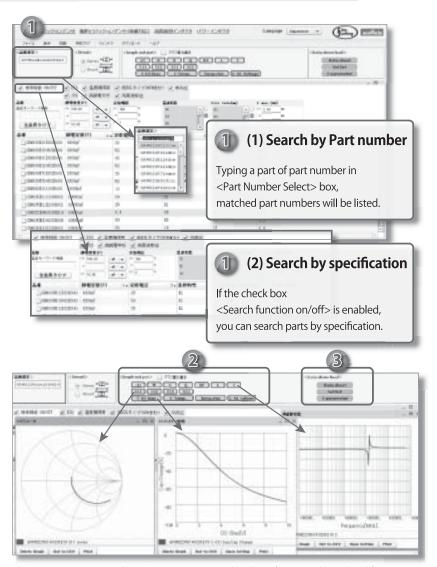
- (1) By part number
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Clicking buttons in this area with partnumber selected, you can view any electrical characteristics chart.

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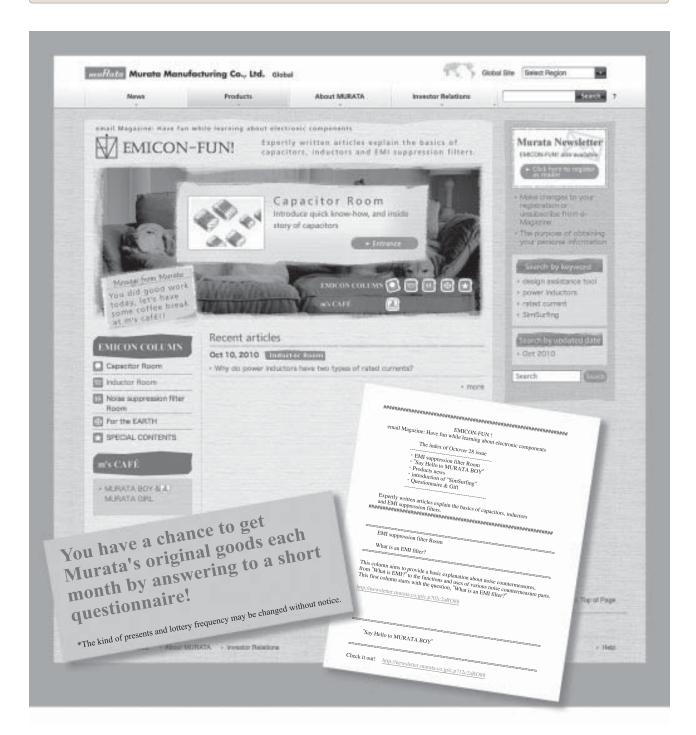


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- Data-processing equipment
- (1) Application of similar complexity and/or reliability requirements to the applications listed above
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